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Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

Product Status	Active
Number of LABs/CLBs	963
Number of Logic Elements/Cells	15408
Total RAM Bits	516096
Number of I/O	81
Number of Gates	-
Voltage - Supply	1.15V ~ 1.25V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	144-LQFP Exposed Pad
Supplier Device Package	144-EQFP (20x20)
Purchase URL	https://www.e-xfl.com/product-detail/intel/ep4ce15e22c6

- Up to 532 user I/Os
 - LVDS interfaces up to 840 Mbps transmitter (Tx), 875 Mbps Rx
 - Support for DDR2 SDRAM interfaces up to 200 MHz
 - Support for QDR II SRAM and DDR SDRAM up to 167 MHz
- Up to eight phase-locked loops (PLLs) per device
- Offered in commercial and industrial temperature grades

Device Resources

Table 1–1 lists Cyclone IV E device resources.

Table 1–1. Resources for the Cyclone IV E Device Family

Resources	EP4CE6	EP4CE10	EP4CE15	EP4CE22	EP4CE30	EP4CE40	EP4CE55	EP4CE75	EP4CE115
Logic elements (LEs)	6,272	10,320	15,408	22,320	28,848	39,600	55,856	75,408	114,480
Embedded memory (Kbits)	270	414	504	594	594	1,134	2,340	2,745	3,888
Embedded 18 × 18 multipliers	15	23	56	66	66	116	154	200	266
General-purpose PLLs	2	2	4	4	4	4	4	4	4
Global Clock Networks	10	10	20	20	20	20	20	20	20
User I/O Banks	8	8	8	8	8	8	8	8	8
Maximum user I/O ⁽¹⁾	179	179	343	153	532	532	374	426	528

Note to Table 1–1:

- (1) The user I/Os count from pin-out files includes all general purpose I/O, dedicated clock pins, and dual purpose configuration pins. Transceiver pins and dedicated configuration pins are not included in the pin count.

Cyclone IV Device Family Speed Grades

Table 1–5 lists the Cyclone IV GX devices speed grades.

Table 1–5. Speed Grades for the Cyclone IV GX Device Family

Device	F169	F324	F484	F672	F896
EP4CGX15	C6, C7, C8, I7	—	—	—	—
EP4CGX22	C6, C7, C8, I7	C6, C7, C8, I7	—	—	—
EP4CGX30	C6, C7, C8, I7	C6, C7, C8, I7	C6, C7, C8, I7	—	—
EP4CGX50	—	—	C6, C7, C8, I7	C6, C7, C8, I7	—
EP4CGX75	—	—	C6, C7, C8, I7	C6, C7, C8, I7	—
EP4CGX110	—	—	C7, C8, I7	C7, C8, I7	C7, C8, I7
EP4CGX150	—	—	C7, C8, I7	C7, C8, I7	C7, C8, I7

Table 1–6 lists the Cyclone IV E devices speed grades.

Table 1–6. Speed Grades for the Cyclone IV E Device Family ⁽¹⁾, ⁽²⁾

Device	E144	M164	M256	U256	F256	F324	U484	F484	F780
EP4CE6	C8L, C9L, I8L C6, C7, C8, I7, A7	—	—	I7N	C8L, C9L, I8L C6, C7, C8, I7, A7	—	—	—	—
EP4CE10	C8L, C9L, I8L C6, C7, C8, I7, A7	—	—	I7N	C8L, C9L, I8L C6, C7, C8, I7, A7	—	—	—	—
EP4CE15	C8L, C9L, I8L C6, C7, C8, I7	I7N	C7N, I7N	I7N	C8L, C9L, I8L C6, C7, C8, I7, A7	—	—	C8L, C9L, I8L C6, C7, C8, I7, A7	—
EP4CE22	C8L, C9L, I8L C6, C7, C8, I7, A7	—	—	I7N	C8L, C9L, I8L C6, C7, C8, I7, A7	—	—	—	—
EP4CE30	—	—	—	—	—	A7N	—	C8L, C9L, I8L C6, C7, C8, I7, A7	C8L, C9L, I8L C6, C7, C8, I7
EP4CE40	—	—	—	—	—	A7N	I7N	C8L, C9L, I8L C6, C7, C8, I7, A7	C8L, C9L, I8L C6, C7, C8, I7
EP4CE55	—	—	—	—	—	—	I7N	C8L, C9L, I8L C6, C7, C8, I7	C8L, C9L, I8L C6, C7, C8, I7
EP4CE75	—	—	—	—	—	—	I7N	C8L, C9L, I8L C6, C7, C8, I7	C8L, C9L, I8L C6, C7, C8, I7
EP4CE115	—	—	—	—	—	—	—	C8L, C9L, I8L C7, C8, I7	C8L, C9L, I8L C7, C8, I7

Notes to Table 1–6:

- (1) C8L, C9L, and I8L speed grades are applicable for the 1.0-V core voltage.
- (2) C6, C7, C8, I7, and A7 speed grades are applicable for the 1.2-V core voltage.

I/O Features

Cyclone IV device I/O supports programmable bus hold, programmable pull-up resistors, programmable delay, programmable drive strength, programmable slew-rate control to optimize signal integrity, and hot socketing. Cyclone IV devices support calibrated on-chip series termination (Rs OCT) or driver impedance matching (Rs) for single-ended I/O standards. In Cyclone IV GX devices, the high-speed transceiver I/Os are located on the left side of the device. The top, bottom, and right sides can implement general-purpose user I/Os.

Table 1-8 lists the I/O standards that Cyclone IV devices support.

Table 1-8. I/O Standards Support for the Cyclone IV Device Family

Type	I/O Standard
Single-Ended I/O	LVTTL, LVCMOS, SSTL, HSTL, PCI, and PCI-X
Differential I/O	SSTL, HSTL, LVPECL, BLVDS, LVDS, mini-LVDS, RSDS, and PPDS

The LVDS SERDES is implemented in the core of the device using logic elements.



For more information, refer to the *I/O Features in Cyclone IV Devices* chapter.

Clock Management

Cyclone IV devices include up to 30 global clock (GCLK) networks and up to eight PLLs with five outputs per PLL to provide robust clock management and synthesis. You can dynamically reconfigure Cyclone IV device PLLs in user mode to change the clock frequency or phase.

Cyclone IV GX devices support two types of PLLs: multipurpose PLLs and general-purpose PLLs:

- Use multipurpose PLLs for clocking the transceiver blocks. You can also use them for general-purpose clocking when they are not used for transceiver clocking.
- Use general purpose PLLs for general-purpose applications in the fabric and periphery, such as external memory interfaces. Some of the general purpose PLLs can support transceiver clocking.



For more information, refer to the *Clock Networks and PLLs in Cyclone IV Devices* chapter.

External Memory Interfaces

Cyclone IV devices support SDR, DDR, DDR2 SDRAM, and QDR II SRAM interfaces on the top, bottom, and right sides of the device. Cyclone IV E devices also support these interfaces on the left side of the device. Interfaces may span two or more sides of the device to allow more flexible board design. The Altera® DDR SDRAM memory interface solution consists of a PHY interface and a memory controller. Altera supplies the PHY IP and you can use it in conjunction with your own custom memory controller or an Altera-provided memory controller. Cyclone IV devices support the use of error correction coding (ECC) bits on DDR and DDR2 SDRAM interfaces.

Table 3-3. Cyclone IV Devices M9K Block Mixed-Width Configurations (Simple Dual-Port Mode) (Part 2 of 2)

Read Port	Write Port								
	8192 × 1	4096 × 2	2048 × 4	1024 × 8	512 × 16	256 × 32	1024 × 9	512 × 18	256 × 36
512 × 16	✓	✓	✓	✓	✓	✓	—	—	—
256 × 32	✓	✓	✓	✓	✓	✓	—	—	—
1024 × 9	—	—	—	—	—	—	✓	✓	✓
512 × 18	—	—	—	—	—	—	✓	✓	✓
256 × 36	—	—	—	—	—	—	✓	✓	✓

In simple dual-port mode, M9K memory blocks support separate *wren* and *rden* signals. You can save power by keeping the *rden* signal low (inactive) when not reading. Read-during-write operations to the same address can either output “Don’t Care” data at that location or output “Old Data”. To choose the desired behavior, set the **Read-During-Write** option to either **Don’t Care** or **Old Data** in the RAM MegaWizard Plug-In Manager in the Quartus II software. For more information about this behavior, refer to “Read-During-Write Operations” on page 3-15.

Figure 3-9 shows the timing waveform for read and write operations in simple dual-port mode with unregistered outputs. Registering the outputs of the RAM simply delays the *q* output by one clock cycle.

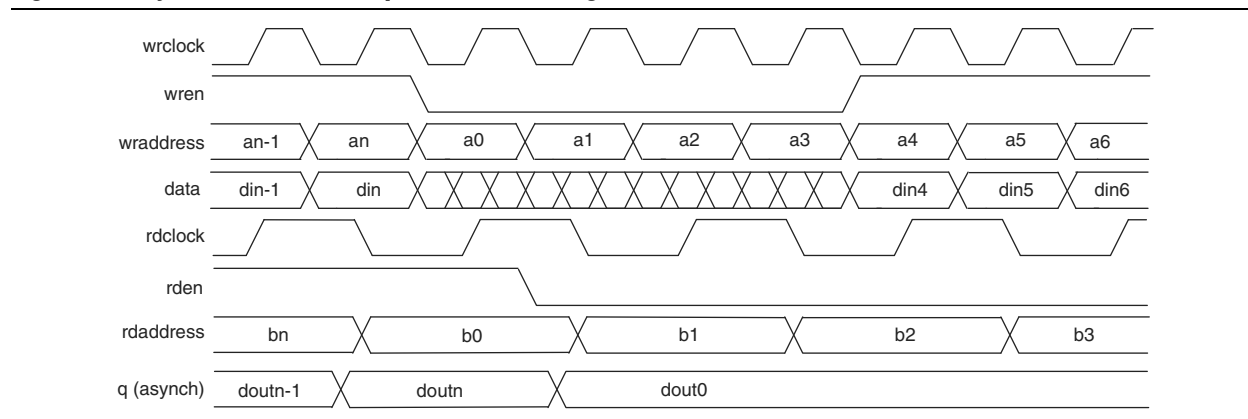
Figure 3-9. Cyclone IV Devices Simple Dual-Port Timing Waveform

Table 4–2 lists the sign of the multiplication results for the various operand sign representations. The results of the multiplication are signed if any one of the operands is a signed value.

Table 4–2. Multiplier Sign Representation

Data A		Data B		Result
signa Value	Logic Level	signb Value	Logic Level	
Unsigned	Low	Unsigned	Low	Unsigned
Unsigned	Low	Signed	High	Signed
Signed	High	Unsigned	Low	Signed
Signed	High	Signed	High	Signed

Each embedded multiplier block has only one *signa* and one *signb* signal to control the sign representation of the input data to the block. If the embedded multiplier block has two 9×9 multipliers, the *Data A* input of both multipliers share the same *signa* signal, and the *Data B* input of both multipliers share the same *signb* signal. You can dynamically change the *signa* and *signb* signals to modify the sign representation of the input operands at run time. You can send the *signa* and *signb* signals through a dedicated input register. The multiplier offers full precision, regardless of the sign representation.



When the *signa* and *signb* signals are unused, the Quartus II software sets the multiplier to perform unsigned multiplication by default.

Output Registers

You can register the embedded multiplier output with output registers in either 18- or 36-bit sections, depending on the operational mode of the multiplier. The following control signals are available for each output register in the embedded multiplier:

- clock
- clock enable
- asynchronous clear

All input and output registers in a single embedded multiplier are fed by the same clock, clock enable, and asynchronous clear signals.

Operational Modes

You can use an embedded multiplier block in one of two operational modes, depending on the application needs:

- One 18×18 multiplier
- Up to two 9×9 independent multipliers



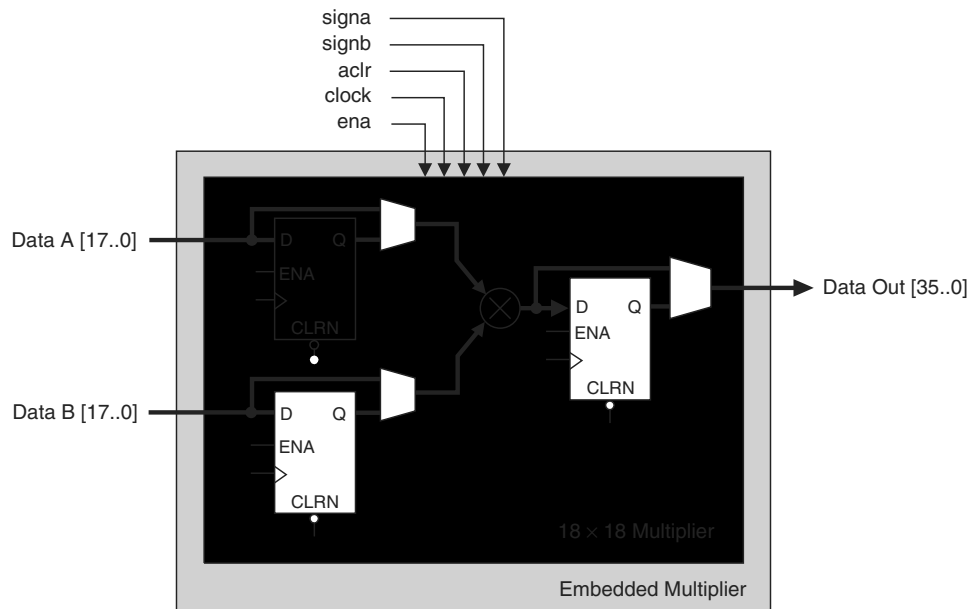
You can also use embedded multipliers of Cyclone IV devices to implement multiplier adder and multiplier accumulator functions, in which the multiplier portion of the function is implemented with embedded multipliers, and the adder or accumulator function is implemented in logic elements (LEs).

18-Bit Multipliers

You can configure each embedded multiplier to support a single 18×18 multiplier for input widths of 10 to 18 bits.

Figure 4-3 shows the embedded multiplier configured to support an 18-bit multiplier.

Figure 4-3. 18-Bit Multiplier Mode



All 18-bit multiplier inputs and results are independently sent through registers. The multiplier inputs can accept signed integers, unsigned integers, or a combination of both. Also, you can dynamically change the **signa** and **signb** signals and send these signals through dedicated input registers.

Table 6–2. Cyclone IV Device I/O Features Support (Part 2 of 2)

I/O Standard	IOH/IOL Current Strength Setting (mA) ⁽¹⁾ , ⁽⁹⁾		R _S OCT with Calibration Setting, Ohm (Ω)		R _S OCT Without Calibration Setting, Ohm (Ω)		Cyclone IV E I/O Banks Support	Cyclone IV GX I/O Banks Support	Slew Rate Option ⁽⁶⁾	PCI-clamp Diode Support
	Column I/O	Row I/O	Column I/O	Row I/O ⁽⁸⁾	Column I/O	Row I/O ⁽⁸⁾				
BLVDS	8,12,16	8,12,16	—	—	—	—	1,2,3,4,5,6,7,8	3,4,5,6,7,8	0,1,2	—
LVDS ⁽³⁾	—	—	—	—	—	—		5,6	—	—
PPDS ⁽³⁾ , ⁽⁴⁾	—	—	—	—	—	—			—	—
RSDS and mini-LVDS ⁽³⁾ , ⁽⁴⁾	—	—	—	—	—	—			—	—
Differential LVPECL ⁽⁵⁾	—	—	—	—	—	—		3,4,5,6,7,8	—	—

Notes to Table 6–2:

- (1) The default current strength setting in the Quartus II software is 50- Ω OCT without calibration for all non-voltage reference and HSTL/SSTL Class I I/O standards. The default setting is 25- Ω OCT without calibration for HSTL/SSTL Class II I/O standards.
- (2) The differential SSTL-18 and SSTL-2, differential HSTL-18, HSTL-15, and HSTL-12 I/O standards are supported only on clock input pins and PLL output clock pins.
- (3) True differential (PPDS, LVDS, mini-LVDS, and RSDS I/O standards) outputs are supported in row I/O banks 1, 2, 5, and 6 only for Cyclone IV E devices and right I/O banks 5 and 6 only for Cyclone IV GX devices. Differential outputs in column I/O banks require an external resistor network.
- (4) This I/O standard is supported for outputs only.
- (5) This I/O standard is supported for clock inputs only.
- (6) The default Quartus II slew rate setting is in bold; **2** for all I/O standards that supports slew rate option.
- (7) Differential SSTL-18, differential HSTL-18, HSTL-15, and HSTL-12 I/O standards do not support Class II output.
- (8) Cyclone IV GX devices only support right I/O pins.
- (9) Altera not only offers current strength that meets the industrial standard specification but also other additional current strengths.



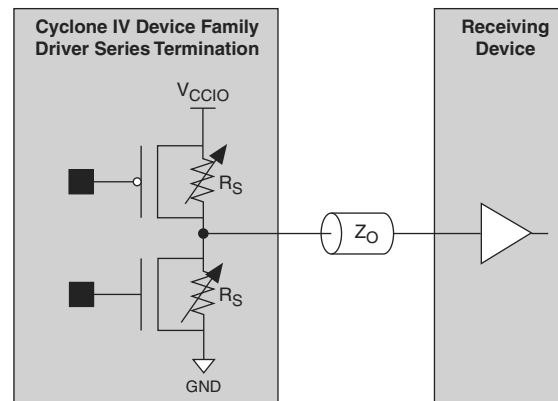
For more details about the differential I/O standards supported in Cyclone IV I/O banks, refer to “High-Speed I/O Interface” on page 6–24.

On-Chip Series Termination with Calibration

Cyclone IV devices support R_S OCT with calibration in the top, bottom, and right I/O banks. The R_S OCT calibration circuit compares the total impedance of the I/O buffer to the external 25- Ω \pm 1% or 50- Ω \pm 1% resistors connected to the RUP and RDN pins, and dynamically adjusts the I/O buffer impedance until they match (as shown in Figure 6–2).

The R_S shown in Figure 6-2 is the intrinsic impedance of the transistors that make up the I/O buffer.

Figure 6-2. Cyclone IV Devices R_S OCT with Calibration



OCT with calibration is achieved using the OCT calibration block circuitry. There is one OCT calibration block in each of I/O banks 2, 4, 5, and 7 for Cyclone IV E devices and I/O banks 4, 5, and 7 for Cyclone IV GX devices. Each calibration block supports each side of the I/O banks. Because there are two I/O banks sharing the same calibration block, both banks must have the same V_{CCIO} if both banks enable OCT calibration. If two related banks have different V_{CCIO} , only the bank in which the calibration block resides can enable OCT calibration.

Figure 6-10 on page 6-18 shows the top-level view of the OCT calibration blocks placement.

Each calibration block comes with a pair of RUP and RDN pins. When used for calibration, the RUP pin is connected to V_{CCIO} through an external $25\text{-}\Omega \pm 1\%$ or $50\text{-}\Omega \pm 1\%$ resistor for an R_S OCT value of $25\text{ }\Omega$ or $50\text{ }\Omega$, respectively. The RDN pin is connected to GND through an external $25\text{-}\Omega \pm 1\%$ or $50\text{-}\Omega \pm 1\%$ resistor for an R_S OCT value of $25\text{ }\Omega$ or $50\text{ }\Omega$, respectively. The external resistors are compared with the internal resistance using comparators. The resultant outputs of the comparators are used by the OCT calibration block to dynamically adjust buffer impedance.



During calibration, the resistance of the RUP and RDN pins varies.

Table 8-4. Configuration Schemes for Cyclone IV GX Devices (EP4CGX30 [only for F484 package], EP4CGX50, EP4CGX75, EP4CGX110, and EP4CGX150) (Part 2 of 2)

Configuration Scheme	MSEL3	MSEL2	MSEL1	MSEL0	POR Delay	Configuration Voltage Standard (V) ⁽¹⁾
JTAG-based configuration ⁽²⁾	(3)	(3)	(3)	(3)	—	—

Notes to Table 8-4:

- (1) Configuration voltage standard applied to the V_{CCIO} supply of the bank in which the configuration pins reside.
- (2) JTAG-based configuration takes precedence over other configuration schemes, which means the MSEL pin settings are ignored.
- (3) Do not leave the MSEL pins floating. Connect them to V_{CCA} or GND. These pins support the non-JTAG configuration scheme used in production. Altera recommends connecting the MSEL pins to GND if your device is only using JTAG configuration.


 Smaller Cyclone IV E devices or package options (E144 and F256 packages) do not have the MSEL[3] pin. The AS Fast POR configuration scheme at 3.0- or 2.5-V configuration voltage standard and the AP configuration scheme are not supported in Cyclone IV E devices without the MSEL[3] pin. To configure these devices with other supported configuration schemes, select MSEL[2..0] pins according to the MSEL settings in Table 8-5.

Table 8-5. Configuration Schemes for Cyclone IV E Devices

Configuration Scheme	MSEL3	MSEL2	MSEL1	MSEL0	POR Delay	Configuration Voltage Standard (V) ⁽¹⁾
AS	1	1	0	1	Fast	3.3
	0	1	0	0	Fast	3.0, 2.5
	0	0	1	0	Standard	3.3
	0	0	1	1	Standard	3.0, 2.5
AP	0	1	0	1	Fast	3.3
	0	1	1	0	Fast	1.8
	0	1	1	1	Standard	3.3
	1	0	1	1	Standard	3.0, 2.5
	1	0	0	0	Standard	1.8
PS	1	1	0	0	Fast	3.3, 3.0, 2.5
	0	0	0	0	Standard	3.3, 3.0, 2.5
FPP	1	1	1	0	Fast	3.3, 3.0, 2.5
	1	1	1	1	Fast	1.8, 1.5
JTAG-based configuration ⁽²⁾	(3)	(3)	(3)	(3)	—	—

Notes to Table 8-5:

- (1) Configuration voltage standard applied to the V_{CCIO} supply of the bank in which the configuration pins reside.
- (2) JTAG-based configuration takes precedence over other configuration schemes, which means the MSEL pin settings are ignored.
- (3) Do not leave the MSEL pins floating. Connect them to V_{CCA} or GND. These pins support the non-JTAG configuration scheme used in production. Altera recommends connecting the MSEL pins to GND if your device is only using JTAG configuration.

The `nSTATUS` and `CONF_DONE` pins on all target devices are connected together with external pull-up resistors, as shown in Figure 8–8 on page 8–26 and Figure 8–9 on page 8–27. These pins are open-drain bidirectional pins on the devices. When the first device asserts `nCEO` (after receiving all its configuration data), it releases its `CONF_DONE` pin. However, the subsequent devices in the chain keep this shared `CONF_DONE` line low until they receive their configuration data. When all target devices in the chain receive their configuration data and release `CONF_DONE`, the pull-up resistor drives a high level on this line and all devices simultaneously enter initialization mode.

Guidelines for Connecting Parallel Flash to Cyclone IV E Devices for an AP Interface

For single- and multi-device AP configuration, the board trace length and loading between the supported parallel flash and Cyclone IV E devices must follow the recommendations listed in Table 8–11. These recommendations also apply to an AP configuration with multiple bus masters.

Table 8–11. Maximum Trace Length and Loading for AP Configuration

Cyclone IV E AP Pins	Maximum Board Trace Length from Cyclone IV E Device to Flash Device (inches)	Maximum Board Load (pF)
DCLK	6	15
DATA[15..0]	6	30
PADD[23..0]	6	30
nRESET	6	30
Flash_nCE	6	30
nOE	6	30
nAVD	6	30
nWE	6	30
I/O ⁽¹⁾	6	30

Note to Table 8–11:

- (1) The AP configuration ignores the `WAIT` signal from the flash during configuration mode. However, if you are accessing flash during user mode with user logic, you can optionally use the normal I/O to monitor the `WAIT` signal from the Micron P30 or P33 flash.

Configuring With Multiple Bus Masters

Similar to the AS configuration scheme, the AP configuration scheme supports multiple bus masters for the parallel flash. For another master to take control of the AP configuration bus, the master must assert `nCONFIG` low for at least 500 ns to reset the master Cyclone IV E device and override the weak 10-k Ω pull-down resistor on the `nCE` pin. This resets the master Cyclone IV E device and causes it to tri-state its AP configuration bus. The other master device then takes control of the AP configuration bus. After the other master device is done, it releases the AP configuration bus, then releases the `nCE` pin, and finally pulses `nCONFIG` low to restart the configuration.

In the AP configuration scheme, multiple masters share the parallel flash. Similar to the AS configuration scheme, the bus control is negotiated by the `nCE` pin.

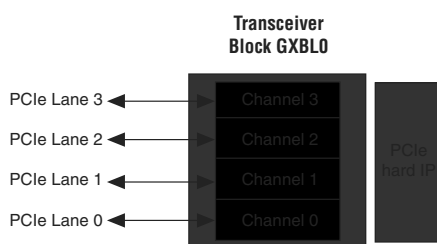
When Cyclone IV devices successfully load the application configuration, they enter user mode. In user mode, the soft logic (the Nios II processor or state machine and the remote communication interface) assists the Cyclone IV device in determining when a remote system update is arriving. When a remote system update arrives, the soft logic receives the incoming data, writes it to the configuration memory device and triggers the device to load the factory configuration. The factory configuration reads the remote system upgrade status register, determines the valid application configuration to load, writes the remote system upgrade control register accordingly, and starts system reconfiguration.

The hard IP block supports 1, 2, or 4 initial lane configurations with a maximum payload of 256 bytes at Gen1 frequency. The application interface is 64 bits with a data width of 16 bits per channel running at up to 125 MHz. As a hard macro and a verified block, it uses very few FPGA resources, while significantly reducing design risk and the time required to achieve timing closure. It is compliant with the PCI Express Base Specification 1.1. You do not have to pay a licensing fee to use this module. Configuring the hard IP block requires using the PCI Express Compiler.

For more information about the hard IP block, refer to the *PCI Express Compiler User Guide*.

Figure 1-43 shows the lane placement requirements when implementing PCIe with hard IP block.

Figure 1-43. PCIe with Hard IP Block Lane Placement Requirements ⁽¹⁾



Note to Figure 1-43:

(1) Applicable for PCIe $\times 1$, $\times 2$, and $\times 4$ implementations with hard IP blocks only.

Transceiver Functional Modes

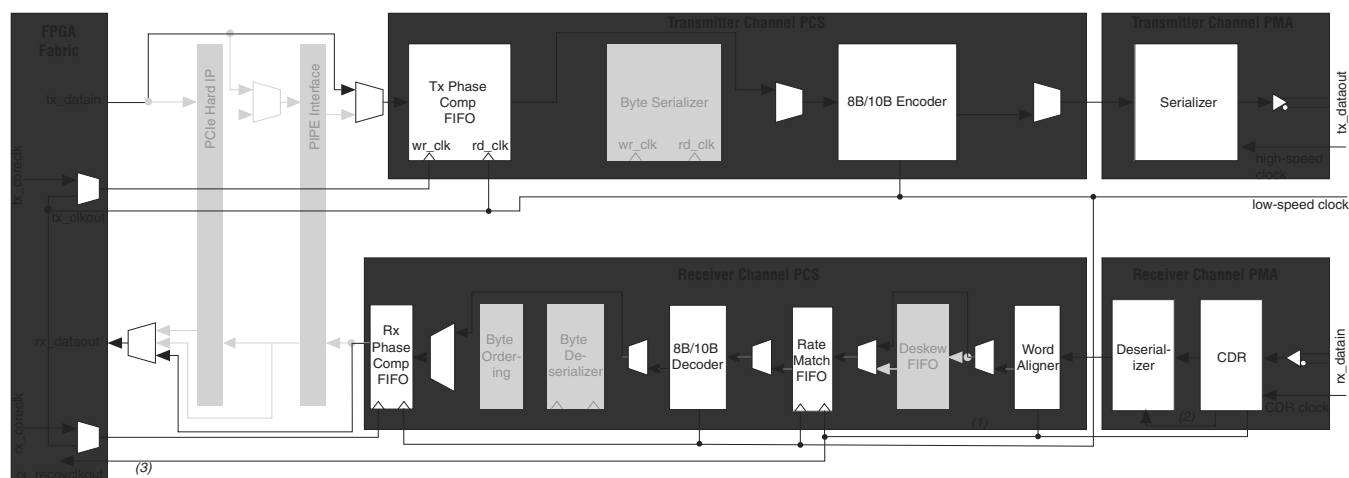
The Cyclone IV GX transceiver supports the functional modes as listed in Table 1-14 for protocol implementation.

Table 1-14. Transceiver Functional Modes for Protocol Implementation (Part 1 of 2)

Functional Mode	Protocol	Key Feature	Reference
Basic	Proprietary, SATA, V-by-One, Display Port	Low latency PCS, transmitter in electrical idle, signal detect at receiver, wider spread asynchronous SSC	"Basic Mode" on page 1-48
PCI Express (PIPE)	PCIe Gen1 with PIPE Interface	PIPE ports, receiver detect, transmitter in electrical idle, electrical idle inference, signal detect at receiver, fast recovery, protocol-compliant word aligner and rate match FIFO, synchronous SSC	"PCI Express (PIPE) Mode" on page 1-52
GIGE	GbE	Running disparity preservation, protocol-compliant word aligner, recovered clock port for applications such as Synchronous Ethernet	"GIGE Mode" on page 1-59
Serial RapidIO	SRIO	Protocol-compliant word aligner	"Serial RapidIO Mode" on page 1-64
XAUI	XAUI	Deskew FIFO, protocol-compliant word aligner and rate match FIFO	"XAUI Mode" on page 1-67

Figure 1-55 shows the transceiver channel datapath and clocking when configured in GIGE mode.

Figure 1-55. Transceiver Channel Datapath and Clocking when Configured in GIGE Mode



Notes to Figure 1-55:

- (1) Low-speed recovered clock.
- (2) High-speed recovered clock.
- (3) Optional `rx_recovclkout` port from CDR low-speed recovered clock is available for applications such as Synchronous Ethernet.

Table 1–21. XGMII Character to PCS Code Groups Mapping (Part 2 of 2)

XGMII TXC ⁽¹⁾	XGMII TXD ^{(2), (3)}	PCS Code Group	Description
1	Any other value	K30.7	Invalid XGMII character

Notes to Table 1–21:

- (1) Equivalent to tx_ctrlenable port.
- (2) Equivalent to 8-bit input data to 8B/10B encoder.
- (3) The values in XGMII TXD column are in hexadecimal.

8B/10B decoder in the receiver datapath maps received PCS code groups into specific 8-bit XGMII codes as listed in Table 1–22.

Table 1–22. PCS Code Groups to XGMII Character Mapping

XGMII RXC ⁽¹⁾	XGMII RXD ^{(2), (3)}	PCS Code Group	Description
0	00 through FF	Dxx,y	Normal data transmission
1	07	K28.0, K28.3, or K28.5	Idle in I
1	07	K28.5	Idle in T
1	9C	K28.4	Sequence
1	FB	K27.7	Start
1	FD	K29.7	Terminate
1	FE	K30.7	Error
1	FE	Invalid code group	Received code group

Notes to Table 1–22:

- (1) Equivalent to rx_ctrlenable port.
- (2) Equivalent to 8-bit input data to 8B/10B encoder.
- (3) The values in XGMII RXD column are in hexadecimal.

Channel Deskewing

The deskew FIFO in each of the four lanes expects to receive /A/ code group simultaneously on all four channels during the inter-packet gap, as required by XAUI protocol. The skew introduced in the physical medium and the receiver channels might cause the /A/ code group to be received misaligned with respect to each other.

The deskew FIFO works to align the /A/ code group across the four channels, which operation is compliant to the PCS deskew state machine diagram specified in clause 48 of the IEEE P802.3ae specification. The deskew operation begins after link synchronization is achieved on all four channels as indicated by the word aligner in each channel. The following are the deskew FIFO operations:

- Until the first /A/ code group is received, the deskew FIFO read and write pointers in each channel are not incremented.
- After the first /A/ code group is received, the write pointer starts incrementing for each word received but the read pointer is frozen.
- When all the four channels received the /A/ code group within 10 recovered clock cycles of each other, the read pointer of all four deskew FIFOs is released simultaneously, aligning the /A/ code group of all four channels in a column.

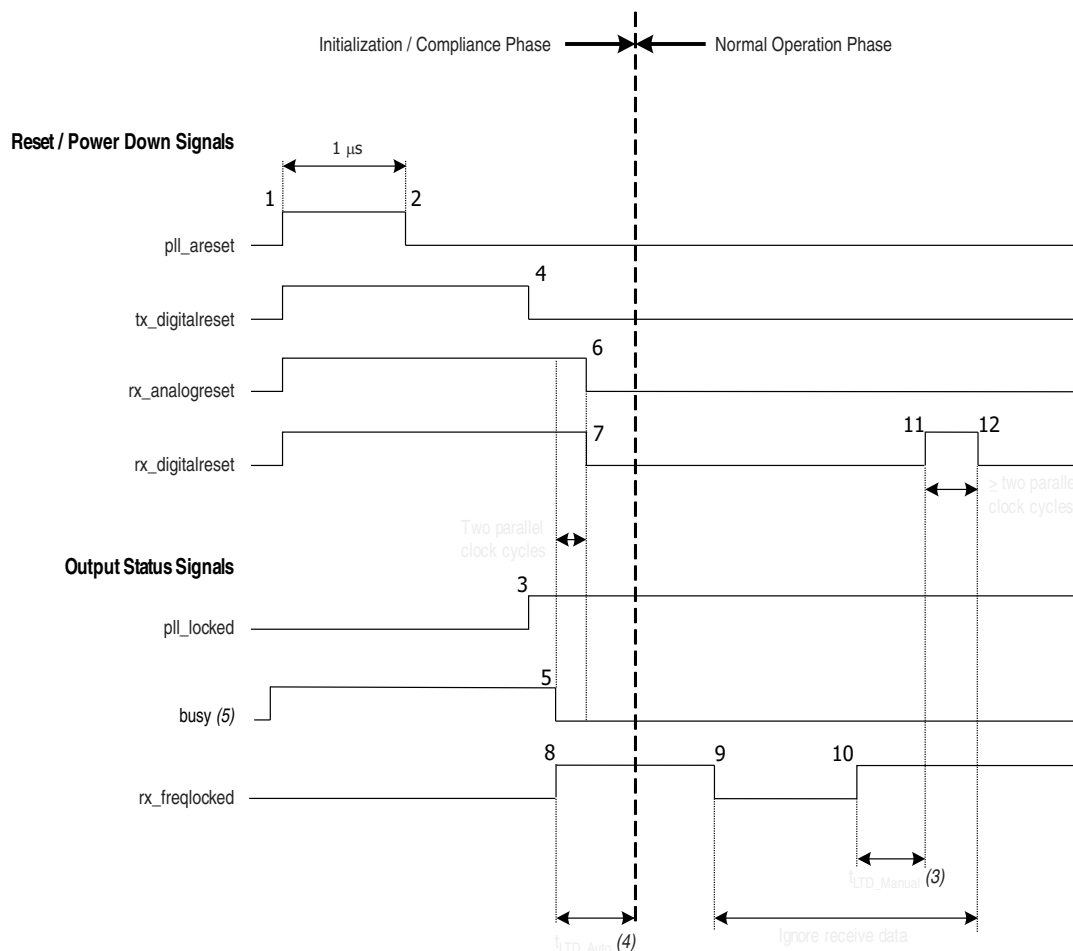
PCIe Functional Mode

You can configure PCIe functional mode with or without the receiver clock rate compensation FIFO in the Cyclone IV GX device. The reset sequence remains the same whether or not you use the receiver clock rate compensation FIFO.

PCIe Reset Sequence

The PCIe protocol consists of an initialization/compliance phase and a normal operation phase. The reset sequences for these two phases are described based on the timing diagram in Figure 2-10.

Figure 2-10. Reset Sequence of PCIe Functional Mode (1), (2)



Notes to Figure 2-10:

- (1) This timing diagram is drawn based on the PCIe Gen 1 ×1 mode.
- (2) For bonded PCIe Gen 1 ×2 and ×4 modes, there will be additional `rx_freqlocked[n]` signal. n=number of channels.
- (3) For t_{LTD_Manual} duration, refer to the *Cyclone IV Device Datasheet* chapter.
- (4) For t_{LTD_Auto} duration, refer to the *Cyclone IV Device Datasheet* chapter.
- (5) The `busy` signal is asserted and deasserted only during initial power up when offset cancellation occurs. In subsequent reset sequences, the `busy` signal is asserted and deasserted only if there is a read or write operation to the `ALTGX_RECONFIG` megafunction.

Table 3–5 describes the rx_dataoutfull[31..0] FPGA fabric-Transceiver channel interface signals.

Table 3–5. rx_dataoutfull[31..0] FPGA Fabric-Transceiver Channel Interface Signal Descriptions (Part 1 of 3)

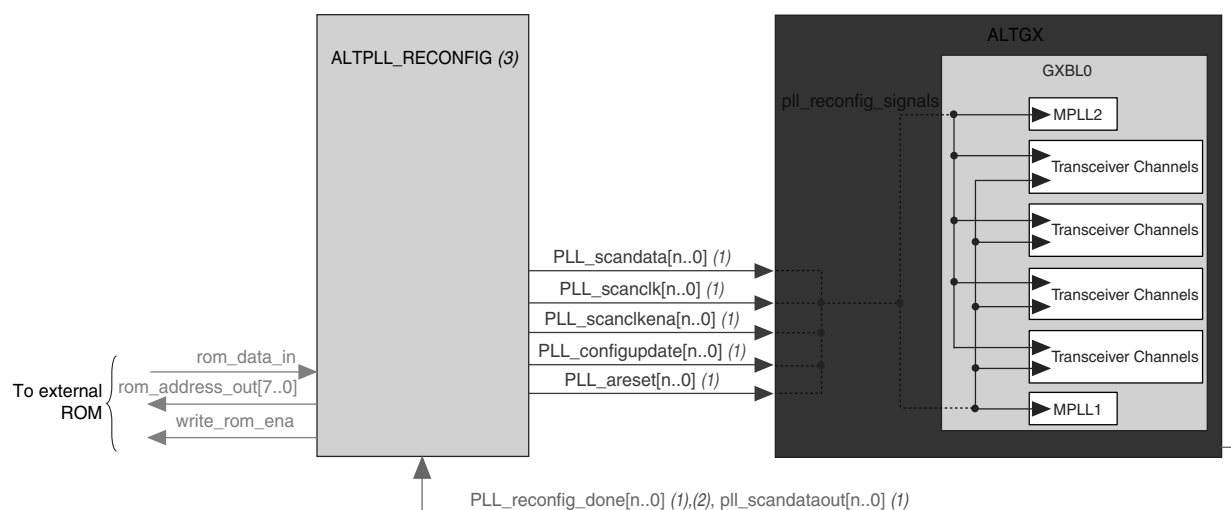
FPGA Fabric-Transceiver Channel Interface Description	Receive Signal Description (Based on Cyclone IV GX Supported FPGA Fabric-Transceiver Channel Interface Widths)
8-bit FPGA fabric-Transceiver Channel Interface	The following signals are used in 8-bit 8B/10B modes:
	rx_dataoutfull[7:0]: 8-bit decoded data (rx_dataout)
	rx_dataoutfull[8]: Control bit (rx_ctrlldetect)
	rx_dataoutfull[9]: Code violation status signal (rx_errdetect)
	rx_dataoutfull[10]: rx_syncstatus
	rx_dataoutfull[11]: Disparity error status signal (rx_disperr)
	rx_dataoutfull[12]: Pattern detect status signal (rx_patterndetect)
	rx_dataoutfull[13]: Rate Match FIFO deletion status indicator (rx_rmfifoatadeleted) in non-PCI Express (PIPE) functional modes.
	rx_dataoutfull[14]: Rate Match FIFO insertion status indicator (rx_rmfifoatinserted) in non-PCI Express (PIPE) functional modes.
	rx_dataoutfull[14:13]: PCI Express (PIPE) functional mode (rx_pipestatus)
	rx_dataoutfull[15]: 8B/10B running disparity indicator (rx_runningdisp)
10-bit FPGA fabric-Transceiver Channel Interface	rx_dataoutfull[9:0]: 10-bit un-encoded data (rx_dataout)
	rx_dataoutfull[10]: rx_syncstatus
	rx_dataoutfull[11]: 8B/10B disparity error indicator (rx_disperr)
	rx_dataoutfull[12]: rx_patterndetect
	rx_dataoutfull[13]: Rate Match FIFO deletion status indicator (rx_rmfifoatadeleted) in non-PCI Express (PIPE) functional modes
	rx_dataoutfull[14]: Rate Match FIFO insertion status indicator (rx_rmfifoatinserted) in non-PCI Express (PIPE) functional modes
	rx_dataoutfull[15]: 8B/10B running disparity indicator (rx_runningdisp)

The .mif file carries the reconfiguration information that will be used to reconfigure the multipurpose PLL or general purpose PLL dynamically. The .mif contents is generated automatically when you select the **Enable PLL Reconfiguration** option in the **Reconfiguration Setting** in ALTGX instances. The .mif files will be generated based on the data rate and input reference clock setting in the ALTGX MegaWizard. You must use the external ROM and feed its content to the ALTPLL_RECONFIG megafunction to reconfigure the multipurpose PLL setting.

For more information about instantiating the ALTPLL_Reconfig, refer to the AN 609: *Implementing Dynamic Reconfiguration in Cyclone IV GX Devices*.

Figure 3-16 shows the connection for PLL reconfiguration mode.

Figure 3-16. ALTGX and ALTPLL_RECONFIG Connection for PLL Reconfiguration Mode



Notes to Figure 3-16:

- (1) $\langle n \rangle = (\text{number of transceiver PLLs configured in the ALTGX MegaWizard}) - 1$.
- (2) You must connect the p1l_reconfig_done signal from the ALTGX to the p1l_scandone port from ALTPLL_RECONFIG.
- (3) You need two ALTPLL_RECONFIG controllers if you have two separate ALTGX instances with transceiver PLL instantiated in each ALTGX instance.

For more information about connecting the ALTPLL_RECONFIG and ALTGX instances, refer to the AN 609: *Implementing Dynamic Reconfiguration in Cyclone IV GX Devices*.

Chapter Revision Dates

The chapters in this document, Cyclone IV Device Handbook, were revised on the following dates. Where chapters or groups of chapters are available separately, part numbers are listed.

Chapter 1. Cyclone IV Device Datasheet
Revised: *December 2016*
Part Number: *CYIV-53001-2.1*

Table 1–42 and Table 1–43 list the IOE programmable delay for Cyclone IV E 1.2 V core voltage devices.

Table 1–42. IOE Programmable Delay on Column Pins for Cyclone IV E 1.2 V Core Voltage Devices ^{(1), (2)}

Parameter	Paths Affected	Number of Setting	Min Offset	Max Offset								Unit
				Fast Corner			Slow Corner					
				C6	I7	A7	C6	C7	C8	I7	A7	
Input delay from pin to internal cells	Pad to I/O dataout to core	7	0	1.314	1.211	1.211	2.177	2.340	2.433	2.388	2.508	ns
Input delay from pin to input register	Pad to I/O input register	8	0	1.307	1.203	1.203	2.19	2.387	2.540	2.430	2.545	ns
Delay from output register to output pin	I/O output register to pad	2	0	0.437	0.402	0.402	0.747	0.820	0.880	0.834	0.873	ns
Input delay from dual-purpose clock pin to fan-out destinations	Pad to global clock network	12	0	0.693	0.665	0.665	1.200	1.379	1.532	1.393	1.441	ns

Notes to Table 1–42:

- (1) The incremental values for the settings are generally linear. For the exact values for each setting, use the latest version of the Quartus II software.
- (2) The minimum and maximum offset timing numbers are in reference to setting **0** as available in the Quartus II software.

Table 1–43. IOE Programmable Delay on Row Pins for Cyclone IV E 1.2 V Core Voltage Devices ^{(1), (2)}

Parameter	Paths Affected	Number of Setting	Min Offset	Max Offset								Unit
				Fast Corner			Slow Corner					
				C6	I7	A7	C6	C7	C8	I7	A7	
Input delay from pin to internal cells	Pad to I/O dataout to core	7	0	1.314	1.209	1.209	2.201	2.386	2.510	2.429	2.548	ns
Input delay from pin to input register	Pad to I/O input register	8	0	1.312	1.207	1.207	2.202	2.402	2.558	2.447	2.557	ns
Delay from output register to output pin	I/O output register to pad	2	0	0.458	0.419	0.419	0.783	0.861	0.924	0.875	0.915	ns
Input delay from dual-purpose clock pin to fan-out destinations	Pad to global clock network	12	0	0.686	0.657	0.657	1.185	1.360	1.506	1.376	1.422	ns

Notes to Table 1–43:

- (1) The incremental values for the settings are generally linear. For the exact values for each setting, use the latest version of the Quartus II software.
- (2) The minimum and maximum offset timing numbers are in reference to setting **0** as available in the Quartus II software.

Table 1–47. Document Revision History

Date	Version	Changes
February 2010	1.1	<ul style="list-style-type: none">■ Updated Table 1–3 through Table 1–44 to include information for Cyclone IV E devices and Cyclone IV GX devices for Quartus II software version 9.1 SP1 release.■ Minor text edits.
November 2009	1.0	Initial release.